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## SN74GTL16622A 18-BIT LVTTL-TO-GTL/GTL+ BUS TRANSCEIVER

SCBS673F-AUGUST 1996-REVISED APRIL 2005

#### **FEATURES**

- Member of Texas Instruments Widebus™
  Family
- OEC™ Circuitry Improves Signal Integrity and Reduces Electromagnetic Interference
- D-Type Flip-Flops With Qualified Storage Fnable
- Translates Between GTL/GTL+ Signal Levels and LVTTL Logic Levels
- Supports Mixed-Mode (3.3 V and 5 V) Signal Operation on A-Port and Control Inputs
- I<sub>off</sub> Supports Partial-Power-Down Mode Operation
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors on A Port
- Distributed V<sub>CC</sub> and GND Pins Minimize High-Speed Noise
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)

#### DESCRIPTION/ORDERING INFORMATION

The SN74GTL16622A is an 18-bit registered bus transceiver that provides LVTTL-to-GTL/GTL+ and GTL/GTL+-to-LVTTL signal-level translation. This device is partitioned as two separate 9-bit transceivers with individual clock-enable controls and contains D-type flip-flops for temporary storage of data flowing in either direction. This device provides an interface between cards operating at LVTTL logic levels and a backplane operating at GTL/GTL+ signal levels. Higher-speed operation is a direct result of the reduced output swing (<1 V), reduced input threshold levels, and OEC™ circuitry.

#### DGG PACKAGE (TOP VIEW)

	- 1		U		1	
OEAB	q	1	$\cup$	64	_	CLKAB
1A1		2		63	0	1CEAB
GND		3		62	þ	_
1A2	Ц	4		61	Р	1B1
1A3	Ц	5		60	p	GND
GND	Ц	6		59	_	1B2
$V_{CC}$	Ц	7		58	0	1B3
1A4	Ц	8		57	0	$V_{CC}$
GND	Ц	9		56	p	1B4
1A5	Ц	10		55	þ	1B5
1A6	Ц	11		54	0	1B6
GND	Ц	12		53	0	GND
1A7	Ц	13		52	þ	1B7
1A8	Ц	14		51	þ	1B8
GND	Ц	15		50	þ	GND
1A9	Ц	16		49	þ	1B9
2A1	Ц	17		48	þ	2B1
GND	Ц	18		47	þ	GND
2A2	Ц	19		46	þ	2B2
2A3	Ц	20		45	þ	2B3
GND	Ц	21		44	P	GND
2A4	Ц	22		43	þ	2B4
2A5	Ц	23		42	0	2B5
GND	Ц	24		41	þ	2B6
2A6	Ц	25		40	þ	$V_{REF}$
$V_{CC}$	Ц	26		39	þ	2B7
GND	Ц	27		38	1	2B8
2A7	Ц	28		37	þ	GND
2A8	Ц	29		36	þ	2B9
GND	Ц	30		35	þ	2CEBA
2A9	Ц	31		34	р	2CEAB
OEBA	4	32		33	Π	CLKBA

The user has the flexibility of using this device at either GTL ( $V_{TT} = 1.2 \text{ V}$  and  $V_{REF} = 0.8 \text{ V}$ ) or the preferred higher noise margin GTL+ ( $V_{TT} = 1.5 \text{ V}$  and  $V_{REF} = 1 \text{ V}$ ) signal levels. GTL+ is the Texas Instruments derivative of the Gunning Transceiver Logic (GTL) JEDEC standard JESD 8-3. The B port normally operates at GTL or GTL+ signal levels, while the A-port and control inputs are compatible with LVTTL logic levels and are 5-V tolerant.  $V_{REF}$  is the reference input voltage for the B port.

Data flow in each direction is controlled by the output-enable (OEAB and OEBA) and clock (CLKAB and CLKBA) inputs. The clock-enable (CEAB and CEBA) inputs control each 9-bit transceiver independently, which makes the device more versatile.

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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## SN74GTL16622A 18-BIT LVTTL-TO-GTL/GTL+ BUS TRANSCEIVER

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### **DESCRIPTION/ORDERING INFORMATION (CONTINUED)**

For A-to-B data flow, the device operates on the low-to-high transition of CLKAB if  $\overline{\text{CEAB}}$  is low. When  $\overline{\text{OEAB}}$  is low, the outputs are active. When  $\overline{\text{OEAB}}$  is high, the outputs are in the high-impedance state. Data flow for B to A is similar to that of A to B, but uses  $\overline{\text{OEBA}}$ , CLKBA, and  $\overline{\text{CEBA}}$ .

This device is fully specified for partial-power-down applications using  $I_{\text{off}}$ . The  $I_{\text{off}}$  circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

Active bus-hold circuitry holds unused or undriven LVTTL inputs at a valid logic state. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

### **ORDERING INFORMATION**

T <sub>A</sub>	PACK	AGE <sup>(1)</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING	
-40°C to 85°C	TSSOP - DGG	Tape and reel	SN74GTL16622ADGGR	GTL16622A	

<sup>(1)</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

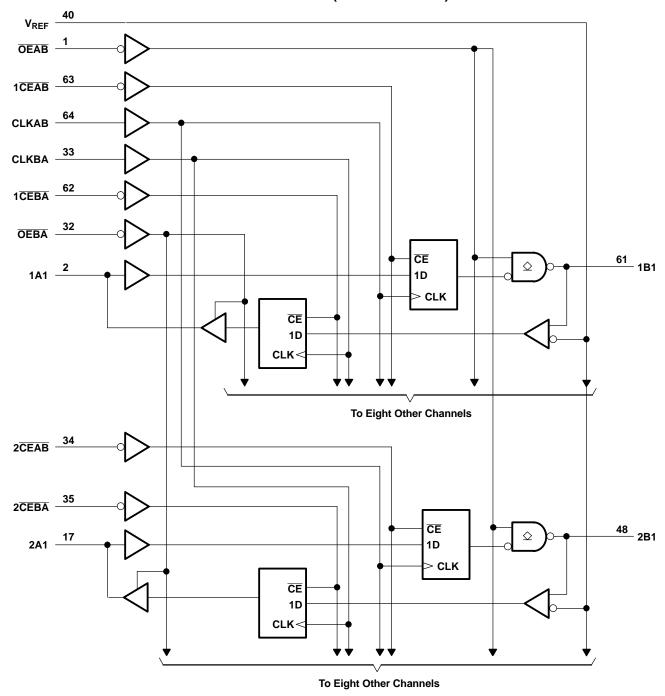
### **FUNCTION TABLE**(1)

	INP	JTS		OUTPUT	MODE
CEAB	OEAB	CLKAB	Α	В	MODE
Х	Н	Х	Х	Z	Isolation
Н	L	X	Χ	B <sub>0</sub> <sup>(2)</sup>	Latabad storage of A data
X	L	H or L	Χ	B <sub>0</sub> <sup>(2)</sup>	Latched storage of A data
L	L	1	L	L	Clasked storage of A data
L	L	$\uparrow$	Н	Н	Clocked storage of A data

- (1) A-to-B data flow is shown. B-to-A data flow is similar, but uses OEBA, CLKBA, and CEBA.
- (2) Output level before the indicated steady-state input conditions are established



## LOGIC DIAGRAM (POSITIVE LOGIC)



## SN74GTL16622A 18-BIT LVTTL-TO-GTL/GTL+ BUS TRANSCEIVER

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## Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage range		-0.5	4.6	V
\/	Input valtage range(2)	A-port and control inputs	-0.5	6.5	V
VI	Input voltage range <sup>(2)</sup>	B port and V <sub>REF</sub>	-0.5	4.6	V
V	Valtage range applied to any output in the high or never off state (2)	-0.5	6.5	V	
Vo	Voltage range applied to any output in the high or power-off state (2)	-0.5	4.6	V	
	A port				Λ
I <sub>O</sub>	Current into any output in the low state	B port		100	mA
Io	Current into any A-port output in the high state (3)	·		48	mA
	Continuous current through each V <sub>CC</sub> or GND			±100	mA
I <sub>IK</sub>	Input clamp current	V <sub>I</sub> < 0		-50	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-50	mA
$\theta_{JA}$	Package thermal impedance (4)		55	°C/W	
T <sub>stg</sub>	Storage temperature range	-65	150	°C	

<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

# Recommended Operating Conditions (1)(2)(3)(4)

			MIN	NOM	MAX	UNIT
$V_{CC}$	Supply voltage		3.15	3.3	3.45	V
V	Tormination valtage	GTL	1.14	1.2	1.26	V
$V_{TT}$	Termination voltage	GTL+	1.35	1.5	1.65	V
V	Deference valtage	GTL	0.74	0.8	0.87	V
V <sub>REF</sub>	Reference voltage	GTL+	0.87	1	1.1	V
V	lanut voltage	B port			V <sub>TT</sub>	V
VI	Input voltage	Except B port			5.5	V
V	High level input valtage	B port	V <sub>REF</sub> + 50 mV			V
V <sub>IH</sub>	High-level input voltage	Except B port	2			V
V	Low lovel input voltage	B port			V <sub>REF</sub> – 50 mV	V
V <sub>IL</sub>	Low-level input voltage	Except B port			0.8	V
I <sub>IK</sub>	Input clamp current				-18	mA
I <sub>OH</sub>	High-level output current	A port			-24	mA
	Low lovel output ourrent	A port			24	A
I <sub>OL</sub>	Low-level output current	B port			50	mA
T <sub>A</sub>	Operating free-air temperature	·	-40		85	°C

<sup>(1)</sup> All unused inputs of the device must be held at  $V_{CC}$  or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

The current flows only when the output is in the high state and  $V_O > V_{CC}$ . The package thermal impedance is calculated in accordance with JESD 51-7.

Normal connection sequence is GND first and  $V_{CC}$  = 3.3 V, I/O, control inputs,  $V_{TT}$  and  $V_{REF}$  (any order) last.  $V_{TT}$  and  $R_{TT}$  can be adjusted to accommodate backplane impedances if the dc recommended  $I_{OL}$  ratings are not exceeded.  $V_{REF}$  can be adjusted to optimize noise margins, but normally is two-thirds  $V_{TT}$ .



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### **Electrical Characteristics**

over recommended operating free-air temperature range for GTL/GTL+ (unless otherwise noted)

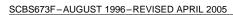
PARAMETER		TEST	CONDITIONS	MIN '	TYP <sup>(1)</sup>	MAX	UNIT
$V_{IK}$		V <sub>CC</sub> = 3.15 V,	I <sub>I</sub> = -18 mA			-1.2	V
		$V_{CC} = 3.15 \text{ V to } 3.45 \text{ V},$	$I_{OH} = -100  \mu A$	V <sub>CC</sub> - 0.2			
$V_{OH}$	A port	V 2.45 V	$I_{OH} = -12 \text{ mA}$	2.4			V
		V <sub>CC</sub> = 3.15 V	$I_{OH} = -24 \text{ mA}$	2			
		$V_{CC} = 3.15 \text{ V to } 3.45 \text{ V},$	I <sub>OL</sub> = 100 μA			0.2	
	A port	V <sub>CC</sub> = 3.15 V	I <sub>OL</sub> = 12 mA			0.4	
		V <sub>CC</sub> = 3.13 V	I <sub>OL</sub> = 24 mA			0.5	
$V_{OL}$		$V_{CC} = 3.15 \text{ V to } 3.45 \text{ V},$	$I_{OL} = 100 \mu A$			0.2	V
	B port		$I_{OL} = 10 \text{ mA}$			0.2	
	В роп	V <sub>CC</sub> = 3.15 V	$I_{OL} = 40 \text{ mA}$			0.4	
			$I_{OL} = 50 \text{ mA}$			0.55	
	B port	$V_{CC} = 3.45 \text{ V},$	$V_I = V_{TT}$ or GND			±5	
I	A part and control inputs	V <sub>CC</sub> = 3.45 V	$V_I = V_{CC}$ or GND			±5	μΑ
	A-port and control inputs	V <sub>CC</sub> = 3.45 V	$V_I = 5.5 \text{ V or GND}$			±20	
I <sub>off</sub>		$V_{CC} = 0$ ,	$V_I$ or $V_O = 0$ to 5.5 V			100	μΑ
		V <sub>CC</sub> = 3.15 V	$V_1 = 0.8 \ V$	75			
$I_{I(hold)}$	A port	VCC = 3.13 V	V <sub>I</sub> = 2 V	-75			μΑ
		$V_{CC} = 3.45 V^{(2)},$	$V_1 = 0.8 \text{ V to 2 V}$			±500	
$I_{OZ}^{(3)}$	A port	$V_{CC} = 3.45 \text{ V},$	$V_O = V_{CC}$ or GND			±10	μΑ
$I_{OZH}$	B port	$V_{CC} = 3.45 \text{ V},$	$V_0 = 1.5 \text{ V}$			10	μΑ
		$V_{CC} = 3.45 \text{ V},$	Outputs high			60	
$I_{CC}$	A or B port	$I_{\Omega} = 0$	Outputs low			60	mA
		$V_I = V_{CC}$ or GND	Outputs disabled			60	
ΔI <sub>CC</sub> <sup>(4)</sup>		$V_{CC}$ = 3.45 V, A-port or cor One input at $V_{CC}$ – 0.6 V	ntrol inputs at V <sub>CC</sub> or GND,			500	μΑ
C <sub>i</sub>	Control inputs	V <sub>I</sub> = 3.15 V or 0			2.5	3	pF
<u> </u>	A port	V = 2.15 V or 0			6	8	nE
$C_{io}$	B port	$V_0 = 3.15 \text{ V or } 0$			6.5	8.5	pF

All typical values are at  $V_{CC} = 3.3 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ . This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to another.

For I/O ports, the parameter  $I_{\text{OZ}}$  includes the input leakage current.

<sup>(4)</sup> This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V<sub>CC</sub> or GND.

## SN74GTL16622A 18-BIT LVTTL-TO-GTL/GTL+ BUS TRANSCEIVER





### **Timing Requirements**

over recommended ranges of supply voltage and operating free-air temperature for GTL (unless otherwise noted)

			MIN	MAX	UNIT
f <sub>clock</sub>	Clock frequency			200	MHz
t <sub>w</sub>	Pulse duration, CLK high or low		2.5		ns
	Catura tima	Data before CLK↑	2.1		
ι <sub>su</sub>	Setup time	<del>CE</del> before CLK↑	3.3		ns
	Hold time	Data after CLK↑	0.3		20
чh	Hold time	0		ns	

## **Switching Characteristics**

over recommended ranges of supply voltage and operating free-air temperature for GTL (see Figure 1)

PARAMETER	FROM (INPUT)	MIN	TYP <sup>(1)</sup> MAX	UNIT	
f <sub>max</sub>			200		MHz
t <sub>PLH</sub>	CLKAB	В	2.5	5.5	ns
t <sub>PHL</sub>	CLRAD	Ь	2.2	5.5	115
t <sub>dis</sub>	OEAB	D	1.7	4.8	
t <sub>en</sub>	OEAB	В	2.2	5.2	ns
Slew rate	Both transition	ons (B port)		0.5	V/ns
t <sub>r</sub>	Transition time, B ou	tputs (0.6 V to 1 V)	0.6	2.2	ns
t <sub>f</sub>	Transition time, B ou	tputs (1 V to 0.6 V)	0.4	1.5	ns
t <sub>PLH</sub>	CLKBA	٨	2.1	5.3	
t <sub>PHL</sub>	CLKBA	A	2.1	5	ns
t <sub>en</sub>	OFDA	٨	1.7	5	
t <sub>dis</sub>	ŌEBĀ	A	2.3	5.5	ns

<sup>(1)</sup> All typical values are at  $V_{CC} = 3.3 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .





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### **Timing Requirements**

over recommended ranges of supply voltage and operating free-air temperature for GTL+ (unless otherwise noted)

			MIN	MAX	UNIT
f <sub>clock</sub>	Clock frequency			200	MHz
t <sub>w</sub>	Pulse duration, CLK high or low		2.5		ns
	Sotup time	Data before CLK↑	2.4		20
<sup>L</sup> su	Setup time	CE before CLK↑	3.2		ns
	Hold time	Data after CLK↑	0.2		20
<sup>t</sup> h	noia time	CE after CLK↑	0		ns

## **Switching Characteristics**

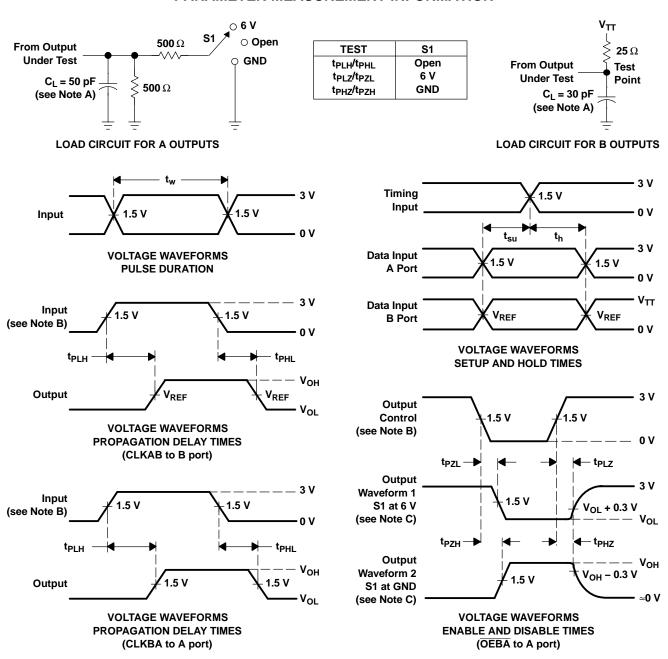
over recommended ranges of supply voltage and operating free-air temperature for GTL+ (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	TYP <sup>(1)</sup>	MAX	UNIT
f <sub>max</sub>			200			MHz
t <sub>PLH</sub>	CLKAB	В	2.6	4	5.6	no
t <sub>PHL</sub>	CLRAB	Б	2.3	4	5.7	ns
t <sub>PLH</sub>	OEAB	В	2.4	3.8	5.2	
t <sub>PHL</sub>	OEAB	Б	1.8	3.4	5	ns
Slew rate	Both transition	ons (B port)		0.5		V/ns
t <sub>r</sub>	Transition time, B out	puts (0.6 V to 1.3 V)	1	1.6	2.7	ns
t <sub>f</sub>	Transition time, B out	puts (1.3 V to 0.6 V)	0.5	1.1	3.2	ns
t <sub>PLH</sub>	CLKBA	Δ.	2	3.8	5.3	
t <sub>PHL</sub>	CLKBA	A	1.9	3.6	5	ns
t <sub>en</sub>	ŌĒBĀ	۸	1.9	3.6	5	20
t <sub>dis</sub>	OEBA	A	2.1	4	5.5	ns

<sup>(1)</sup> All typical values are at  $V_{CC}$  = 3.3 V,  $T_A$  = 25°C.



#### PARAMETER MEASUREMENT INFORMATION



- NOTES: A.  $C_L$  includes probe and jig capacitance.
  - B. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O$  = 50  $\Omega$ ,  $t_r \leq$  2.5 ns,  $t_f \leq$  2.5 ns.
  - C. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
  - D. The outputs are measured one at a time, with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms





20-Jul-2011

#### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/ Ball Finish	MSL Peak Temp <sup>(3)</sup>	Samples (Requires Login)
74GTL16622ADGGRE4	ACTIVE	TSSOP	DGG	64	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
74GTL16622ADGGRG4	ACTIVE	TSSOP	DGG	64	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN74GTL16622ADGGR	ACTIVE	TSSOP	DGG	64	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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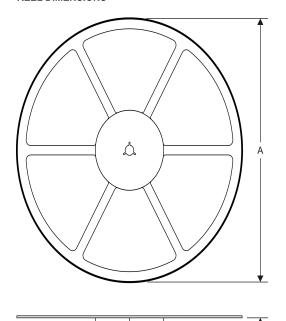
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# PACKAGE MATERIALS INFORMATION

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### TAPE AND REEL INFORMATION

### **REEL DIMENSIONS**



### **TAPE DIMENSIONS**



A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

### TAPE AND REEL INFORMATION

\*All dimensions are nominal

Device	_	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74GTL16622ADGGR	TSSOP	DGG	64	2000	330.0	24.4	8.4	17.3	1.7	12.0	24.0	Q1

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#### \*All dimensions are nominal

	Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
S	N74GTL16622ADGGR	TSSOP	DGG	64	2000	367.0	367.0	45.0

### DGG (R-PDSO-G\*\*)

### PLASTIC SMALL-OUTLINE PACKAGE

#### **48 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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